Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	r	
10/796,470	SHIH ET AL.		
Examiner	Art Unit		
Edna Wong	1753		

	SEAR	CHED	
Class	Subclass	Date	Examiner
106	1.26	1/9/2006	EW
205	296	1/9/2006	EW
205	261	1/9/2006	EW

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			
	<u> </u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Search	1/9/2006	EW
EAST	1/9/2006	EW
Search Updated	5/26/2006	EW